

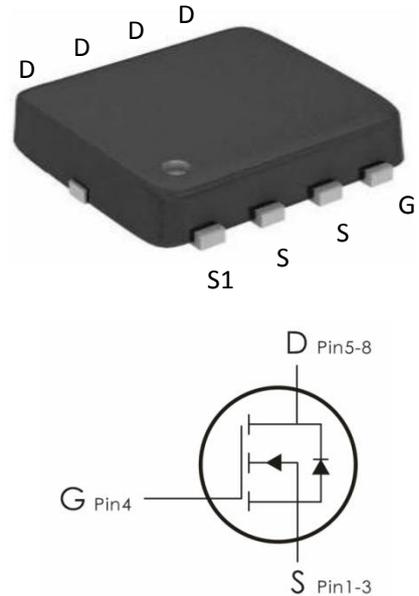
Description:

This N-Channel MOSFET uses advanced trench technology and design to provide excellent $R_{DS(on)}$ with low gate charge.

It can be used in a wide variety of applications.

Features:

- 1) $V_{DS}=40V, I_D=22A, R_{DS(ON)}<22m\Omega @V_{GS}=10V$
- 2) Improved dv/dt capability
- 3) Fast switching
- 4) 100% EAS Guaranteed
- 5) Green Device Available.



Absolute Maximum Ratings:

Symbol	Parameter	Ratings	Units
V_{DS}	Drain-Source Voltage	40	V
V_{GS}	Gate-Source Voltage	± 20	V
I_D	Continuous Drain Current-Continuous- $T_C=25^\circ C$	22	A
	Continuous Drain Current-Continuous- $T_C=100^\circ C$	14	
I_{DM}	Drain Current – Pulsed ^{note1}	65	A
EAS	Single Pulse Avalanche Energy ^{note2}	16	mJ
P_D	Power Dissipation - $T_C=25^\circ C^4$	15.6	W
T_J, T_{STG}	Operating and Storage Junction Temperature Range	-55 to +150	$^\circ C$

Thermal Characteristics:

Symbol	Parameter	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction to Case	6.9	$^{\circ}\text{C}/\text{W}$

Package Marking and Ordering Information:

Part NO.	Marking	Package
ZD020NG	D020N	DFN3*3-8

Electrical Characteristics: ($T_C=25^{\circ}\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
Off Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=250\ \mu\text{A}$	40	---	---	V
I_{DSS}	Drain-Source Leakage Current	$V_{GS}=0V, V_{DS}=40V$	---	---	1.0	μA
I_{GSS}	Gate-Source Leakage Current	$V_{GS}=\pm 20V, V_{DS}=0A$	---	---	± 100	nA
On Characteristics						
$V_{GS(th)}$	GATE-Source Threshold Voltage	$V_{GS}=V_{DS}, I_D=250\ \mu\text{A}$	1	1.5	2.5	V
$R_{DS(on)}$	Drain-Source On Resistance ^②	$V_{GS}=10V, I_D=8A$	---	17	22	m Ω
		$V_{GS}=4.5V, I_D=5A$	---	25	35	
Dynamic Characteristics						
C_{iss}	Input Capacitance	$V_{DS}=20V, V_{GS}=0V, f=1\text{MHz}$	---	523	---	pF
C_{oss}	Output Capacitance		---	62	---	
C_{rss}	Reverse Transfer Capacitance		---	53	---	
Switching Characteristics						
$t_{d(on)}$	Turn-On Delay Time	$V_{DD}=20V, R_L=2.5\ \Omega$ $V_{GS}=10V, R_{REN}=3\ \Omega$	---	4	---	ns
t_r	Rise Time		---	3	---	ns
$t_{d(off)}$	Turn-Off Delay Time		---	15	---	ns
t_f	Fall Time		---	2	---	ns
Q_g	Total Gate Charge	$V_{DS}=20V, V_{GS}=10V, I_D=8A$	---	12	---	nC
Q_{gs}	Gate-Source Charge		---	3.2	---	nC

Q_{gd}	Gate-Drain "Miller" Charge		---	3.1	---	nC
Drain-Source Diode Characteristics						
I_S	Continuous Source Current ^{1,5}	V _G =V _D =0V , Force Current	---	---	8	A
I_{SM}	Pulsed Source Current ^{2,5}		---	---	32	A
V_{SD}	Forward on voltage ^②	I _{SD} =1A, T _J =25°C, V _{GS} =0V	---	---	1.2	V

Notes:

1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature
2. EAS condition : T_J=25°C, V_{DD}=20V, V_G=10V, L=0.5mH, R_g=25Ω, I_{AS}=7.2A
T_J=25°C, V_{DD}=-20V, V_G= -10V, L=0.5mH, R_g=25Ω, I_{AS}=-8.4A
3. Pulse Test: Pulse Width≤300μs, Duty Cycle≤2%

Typical Characteristics: (T_c=25°C unless otherwise noted)

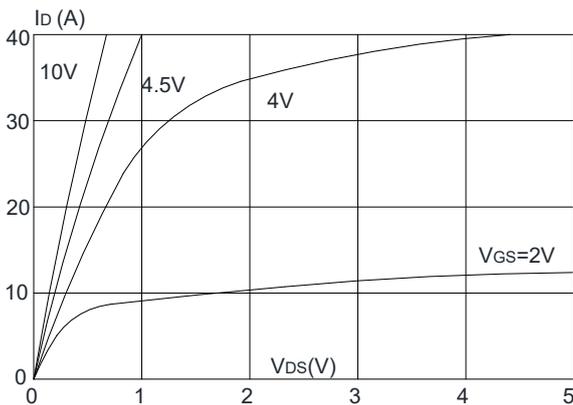


Figure 1: Output Characteristics

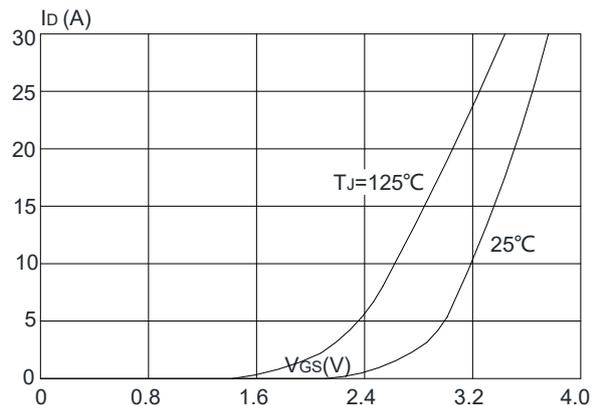


Figure 2: Typical Transfer Characteristics

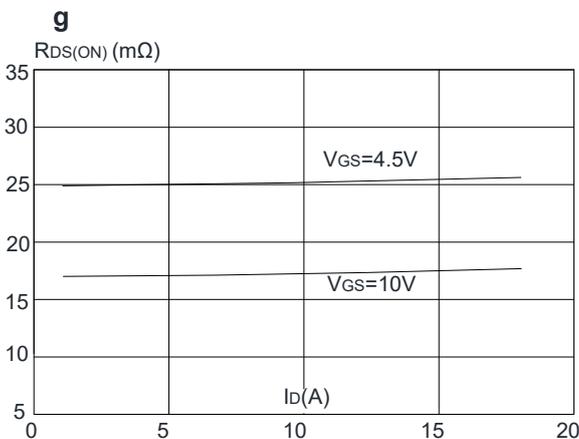


Figure 3: On-resistance vs. Drain Current

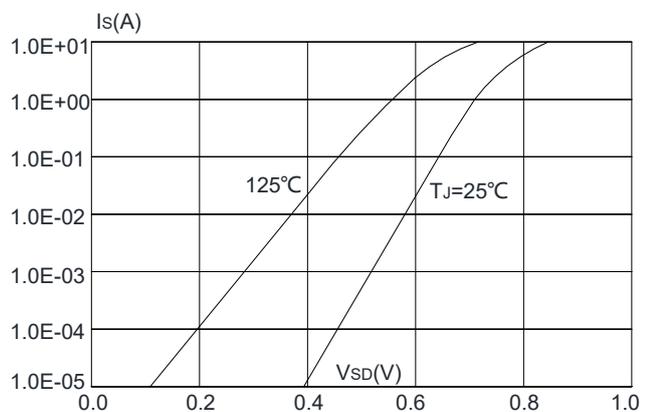


Figure 4: Body Diode Characteristics

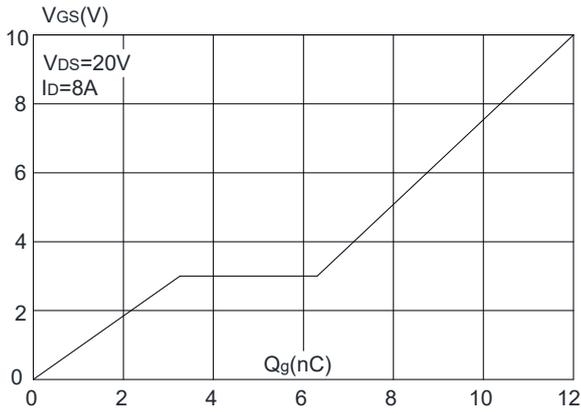


Figure 5: Gate Charge Characteristics

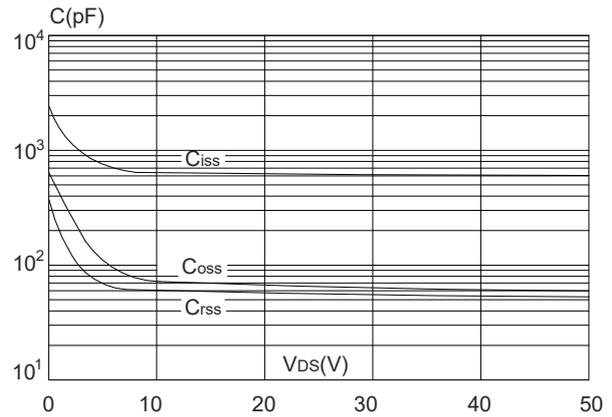


Figure 6: Capacitance Characteristics

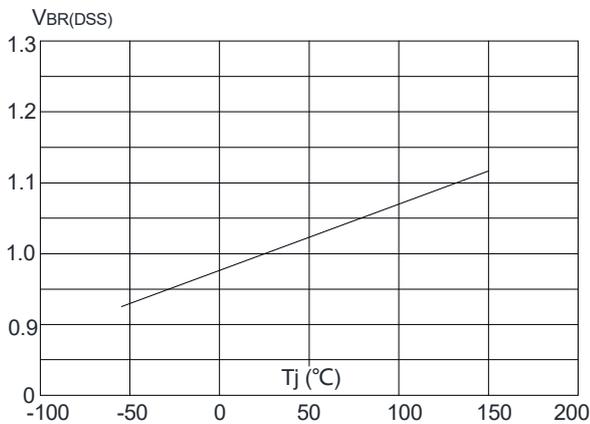


Figure 7: Normalized Breakdown Voltage vs. Junction Temperature

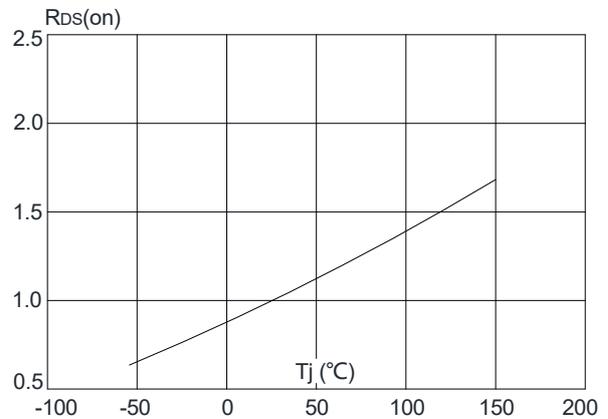


Figure 8: Normalized on Resistance vs. Junction Temperature

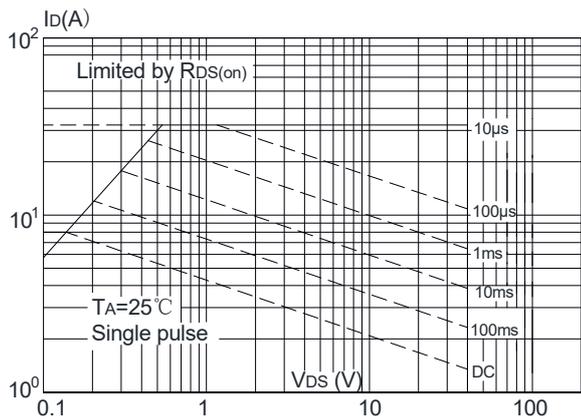


Figure 9: Maximum Safe Operating Area

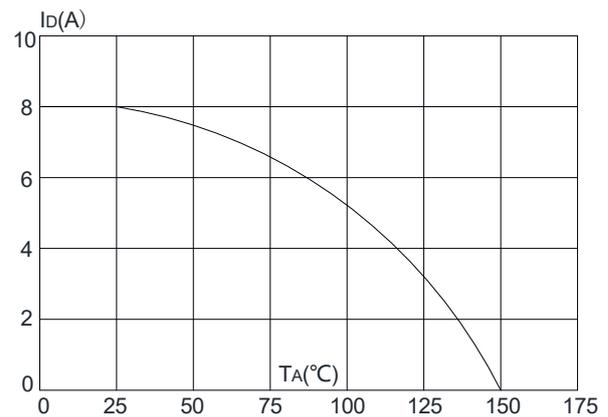


Figure 10: Maximum Continuous Drain Current vs. Ambient Temperature

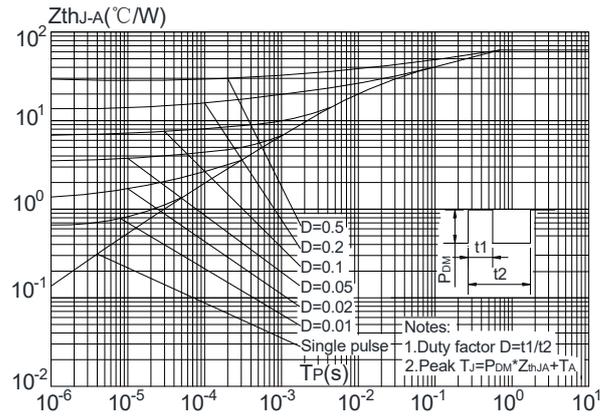


Figure.11: Maximum Effective Transient Thermal Impedance, Junction-to-Ambient